

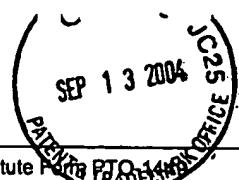
Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 12732-201001	Application No. 10/743,344
<b>Information Disclosure Statement</b> <b>by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant <b>Kazutaka Inukai</b> Filing Date <b>December 23, 2003</b> Group Art Unit <b>2629</b>			

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
XW	AA	2003/0164685	09/04/2003	INUKAI			
XW	AB	2004/0041752	03/04/04	KIMURA			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes      No
	AL						
	AM						
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature <i>/Xiao Wu/</i>	Date Considered <i>08/01/2006</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



Sheet 1 of 1

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<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Kazutaka Inukai	
		Filing Date December 23, 2003	Group Art Unit <b>2629</b>

### U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
XW	AA	5,748,165	05/05/1998	Kubota et al.			
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XW	AC	6,229,506 B1	05/08/2001	Dawson et al.			
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	AI						

### Foreign Patent Documents or Published Foreign Patent Applications

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							Yes	No
XW	AJ	08-137443	05/31/1996	JAPAN			Abstract	
XW	AK	11-282419	10/15/1999	JAPAN			Abstract	
XW	AL	2002-514320	05/14/2002	JAPAN			Abstract	
XW	AM	WO 98/48403	10/29/1998	WIPO/PCT			In English	
XW	AN	EP 1 333 422 A1	08/06/2003	EUROPE			In English	

### Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
XW	AO	International Search Report (Application No. PCT/JP03/16357), March 30, 2004, partial translation, 4 pages
XW	AP	International Preliminary Examination Report (Application No. PCT/JP03/16357), May 11, 2004, partial translation, 5 pages
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<b>Information Disclosure Statement</b> by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Kazutaka Inukai	
		Filing Date December 23, 2003	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
XW	AA	US 2003/0164685 A1	09/04/2003	Inukai			02/28/2003
XW	AB	6,091,203	07/18/2000	Kawashima et al.			03/25/1999
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Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
XW	AL	2003-255896	09/10/2003	JAPAN			ABS
XW	AM	2001-147659	05/29/2001	JAPAN			ABS
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Examiner Initial	Desig. ID	Document
XW	AQ	I.M. Hunter et al.; "Active Matrix Addressing of Polymer Light Emitting Diodes Using Low Temperature Poly Silicon TFTs"; <i>AM-LCD 2000</i> ; pp. 249-252; 2000
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